



FORM PTO-1449 (Modified) INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)		Docket No. P0298US-7	Application Number 10/666,399
		Applicants LEUNG, MICHAEL S.	
		Filing Date September 18, 2003	Group Art Unit 2814

## U.S. PATENT DOCUMENTS

Examiner Initial	Document Number							Date	Name	Class	Subclass	Filing Date If Appropriate
/A.K./	6	6	4	2	6	5	2	11/2003	COLLINS, III	313	512	
↓	6	8	1	2	5	0	0	11/2004	REEH et al.	257	98	
	7	0	2	9	9	3	5	04/2006	NEGLEY, et al.	438	2929	

## FOREIGN PATENT DOCUMENTS

	Document Number							Date	Country	Class	Subclass	Translation	
												Yes	No
/A.K./	JP	20	05	29	88	17		10/2005	JAPAN				X
↓	JP	20	06	05	42	09		02/2006	JAPAN				X
	WO	20	07	01	85	60		02/2007	PCT				
	WO	20	05	10	19	09		10/2005	PCT				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/A.K./	US PUBLICATION NO. US 2007/0096131 A1, 05/03/2007, CHANDRA
Examiner	/Abul Kalam/
Date Considered	04/10/2008
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /AK/



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/A.K./	5	3	9	3	9	9	3	02/1995	EDMOND et al.	257	77	
	5	3	3	8	9	4	4	08/1994	EDMOND et al.	257	76	
	5	2	7	7	8	4	0	01/1994	OSAKA et al.	252	301.36	
	5	2	1	0	0	5	1	05/1993	CARTER, JR.	437	107	
	5	0	2	7	1	6	8	06/1991	EDMOND	357	17	
	4	9	6	6	8	6	2	10/1990	EDMOND	437	100	
	4	9	1	8	4	9	7	04/1990	EDMOND	357	17	
	7	1	8	3	5	8	7	02/2007	NEGLEY et al.	257	99	
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## FOREIGN PATENT DOCUMENTS

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												Yes	No

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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/A.K./	6	2	0	1	2	6	2		03/2001	EDMOND et al.	257	77	
	6	1	8	7	6	0	6		02/2001	EDMOND et al.	438	46	
	6	1	2	0	6	0	0		09/2000	EDMOND et al.	117	89	
	6	0	6	9	4	4	0		05/2000	SHIMIZU et al.	313	486	
	5	9	1	2	4	7	7		06/1999	NEGLEY	257	95	
	5	8	5	8	2	7	8		01/1999	ITOH et al.	252	301.4R	
	5	7	3	9	5	5	4		04/1998	EDMOND et al.	257	103	
	5	6	3	1	1	9	0		05/1997	NEGLEY	438	33	
	5	6	0	4	1	3	5		02/1997	EDMOND et al.	437	22	
	5	5	2	3	5	8	9		06/1996	EDMOND et al.	257	77	
	5	4	1	6	3	4	2		05/1995	EDMOND et al.	257	76	

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	Document Number								Date	Country	Class	Subclass	Translation	
													Yes	No

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/A.K./ ↓		US PUBLICATION NO. US 2004/0056260 A1, DATE: 03/25/2004, SLATER, JR. et al.
		US PUBLICATION NO. US 2004/0041222 A1, DATE: 03/04/2004, LOH
		US PUBLICATION NO. US 2003/0006418 A1, DATE: 01/09/2003, EMERSON et al.
		US PUBLICATION NO. US 2002/0123164 A1, DATE: 09/05/2002, SLATER, JR. et al.
Examiner /Abul Kalam/		Date Considered 04/10/2008
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/A.K./	RE	3	4	8	6	1		02/1995	DAVIS et al.	437	100	
	4	9	4	6	5	4	7	08/1990	PALMOUR et al.	156	643	
	5	2	0	0	0	2	2	04/1993	KONG et al.	156	612	
	7	0	4	9	1	5	9	05/2006	LOWERY	438	22	
	6	6	5	3	7	6	5	11/2003	LEVINSON	313	112	
	6	9	1	9	6	8	3	07/2005	JANG, JAE-EUN	313	503	
	6	7	9	1	1	1	9	09/2004	SLATER, JR. et al.	257	99	
	6	9	5	8	4	9	7	10/2005	EMERSON et al.	257	94	
	6	8	5	3	0	1	0	02/2005	SLATER, JR. et al.	257	98	
	7	2	0	2	5	9	8	04/2007	JUESTEL et al.	313	503	

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/A.K./	WO	20	06	03	36	95	A2	03/30/06	PCT				
	WO	20	06	03	62	51	A1	04/06/06	PCT				
	EP	13	67	6	5	5		12/03/03	EUROPE				
	EP	11	38	7	4	7		10/04/01	EUROPE				
	EP	10	59	67	8			12/2000	EUROPE				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/A.K./	LAU, JOHN, "FLIP-CHIP TECHNOLOGIES", MCGRAW HILL, 1996.
/A.K./	INTERNATIONAL MATERIALS REVIEWS, "MATERIALS FOR FIELD EMISSION DISPLAYS", A.P. BURDEN 2001.
/A.K./	U.S. PUBLICATION NO. US 2002/0105266, JUESTEL et al. 08/08/2002.
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